

7N95K3-VB TO220F Datasheet

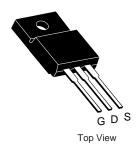
N-Channel 900 V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	900				
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	0.95			
Q _g (Max.) (nC)	200				
Q _{gs} (nC)	24				
Q _{gd} (nC)	110				
Configuration	Single				

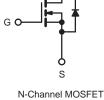
TO-220 FULLPAK

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC







ABSOLUTE MAXIMUM RATINGS ($T_{\mbox{\scriptsize C}}$	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	900	- V	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current		T _C = 25 °C	I_	7.0		
Continuous Drain Current		T _C = 100 °C	ID	5.5	A	
Pulsed Drain Current ^a			I _{DM}	21		
Linear Derating Factor				1.5	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	770	mJ	
Repetitive Avalanche Current ^a			I _{AR}	7.8	A	
Repetitive Avalanche Energy ^a			E _{AR}	19	mJ	
Maximum Power Dissipation	T _C = 25 °C		PD	65	W	
Peak Diode Recovery dV/dt ^c			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for	10 s	-	300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ∙ in	
Mounting Torque				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 23 mH, $R_g = 25 \Omega$, $I_{AS} = 7.8 \text{ A}$ (see fig. 12). c. $I_{SD} \le 7.8 \text{ A}$, dl/dt $\le 140 \text{ A/}\mu\text{s}$, $V_{DD} \le 600 \text{ V}$, $T_J \le 150 \text{ °C}$. d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply



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THERMAL RESISTANCE RATI	NGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	- 40					
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24		-			°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-		0.65				
SPECIFICATIONS ($T_J = 25 \ ^{\circ}C$, u	nless otherwi	se noted)						
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D =	250 µA	900	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	, I _D = 1 mA	-	0.98	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D =	250 µA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20$) V	-	-	± 100	nA
		V _{DS} =	= 900 V, Vo	_{as} = 0 V	-	-	100	
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 720 \	/, V _{GS} = 0 \	V, T _J = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	١ _c	_D = 5.6 A ^b		0.95	-	Ω
Forward Transconductance	g fs	V _{DS} =	= 100 V, I _D =	= 5.6 A ^b	5.6	-	-	S
Dynamic		1				I		
Input Capacitance	C _{iss}		V _{GS} = 0 \	1	-	3100	-	
Output Capacitance	C _{oss}	-	$V_{DS} = 25$	V,	-	800	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, se	e fig. 5	-	490	-	
Total Gate Charge	Qg				-	-	200	1
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 3.8 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 ^b		-	-	24	nC
Gate-Drain Charge	Q _{gd}	-	5661	ig. 0 and 15	-	-	110	1
Turn-On Delay Time	t _{d(on)}				-	19	-	
Rise Time	t _r	V _{DD} = 400 V, I _D = 5.6 A,		-	38	-	1	
Turn-Off Delay Time	t _{d(off)}	R _g =	= 6.2 Ω, R _D see fig. 10		-	120	-	ns
Fall Time	t _f	-	see lig. It		-	39	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	- nH	
Internal Source Inductance	Ls			-	13	-		
Drain-Source Body Diode Characteristic	s				L	ı	l	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0	^	
Pulsed Diode Forward Current ^a	I _{SM}			_	-	21	A	
Body Diode Voltage	V _{SD}	T _J = 25 °C	C, I _S = 5.6 A	A, V _{GS} = 0 V ^b	-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}		25 °C, I _F =		-	650	980	ns
Body Diode Reverse Recovery Charge	Q _{rr}		/dt = 100 A		-	3.8	5.7	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time	is negligible (turn	-on is do			•

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.





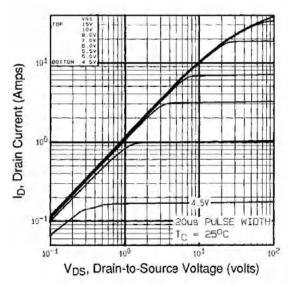


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

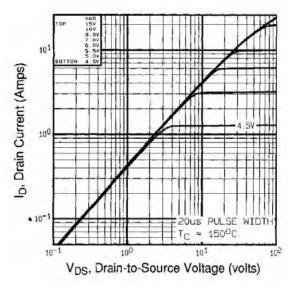


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

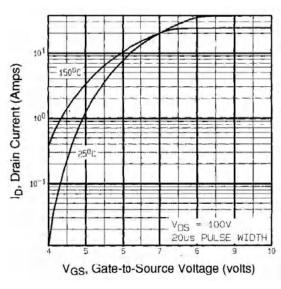
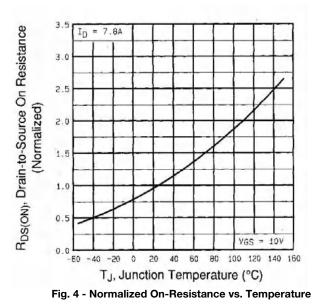


Fig. 3 - Typical Transfer Characteristics





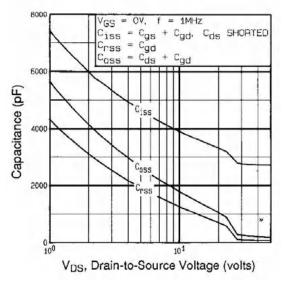


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

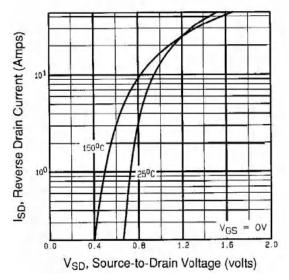


Fig. 7 - Typical Source-Drain Diode Forward Voltage

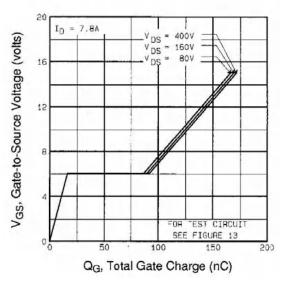
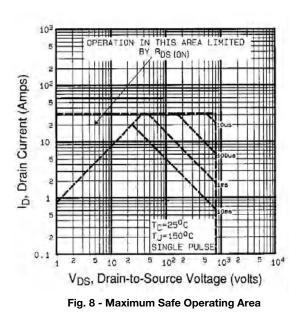


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





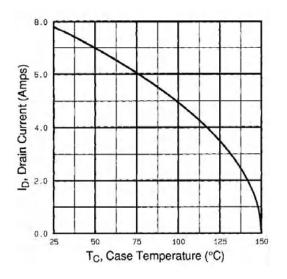


Fig. 9 - Maximum Drain Current vs. Case Temperature

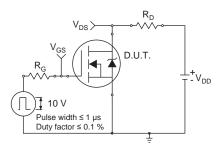


Fig. 10a - Switching Time Test Circuit



Fig. 10b - Switching Time Waveforms

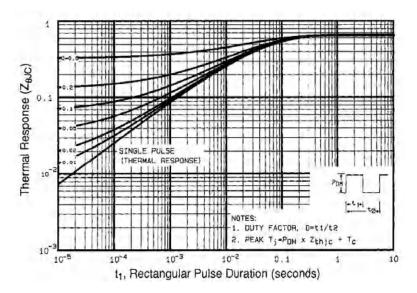


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



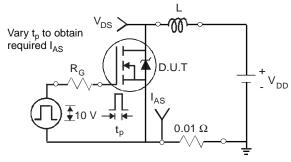


Fig. 12a - Unclamped Inductive Test Circuit

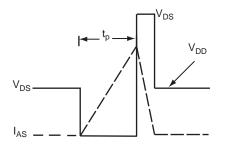


Fig. 12b - Unclamped Inductive Waveforms

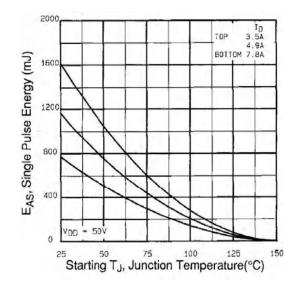


Fig. 12c - Maximum Avalanche Energy vs. Drain Current



Fig. 13a - Basic Gate Charge Waveform

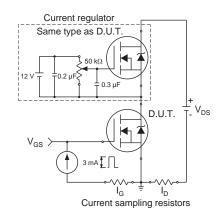
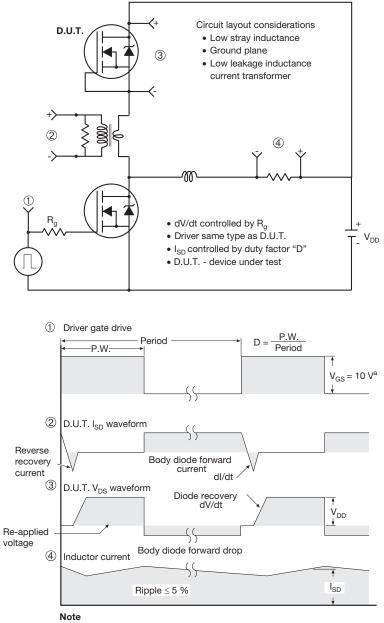


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

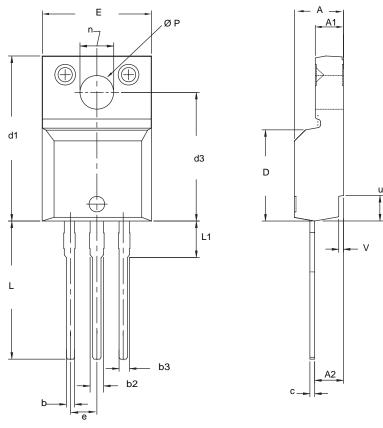


a. $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)



	MILLI	METERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
С	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
E	10.360	10.630	0.408	0.419
е	2.54	4 BSC	0.100 BSC	
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
Ø P	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	0.098
V	0.400	0.500	0.016	0.020

Notes

1. To be used only for process drawing. 2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads. 3. All critical dimensions should C meet $C_{pk} > 1.33$. 4. All dimensions include burrs and plating thickness.

5. No chipping or package damage.



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